

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/633,826	<b>Applicant(s)/Patent under Reexamination</b> KIUCHI ET AL.
	<b>Examiner</b> Basia Ridley 	<b>Art Unit</b> 1764

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner